

### STW11NK90Z

# N-channel 900V - $0.82\Omega$ - 9.2A - TO-247 Zener-protected SuperMESH<sup>TM</sup> Power MOSFET

### **General features**

| Туре       | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> | Pw   |
|------------|------------------|---------------------|----------------|------|
| STW11NK90Z | 900V             | <0.98Ω              | 9.2A           | 200W |

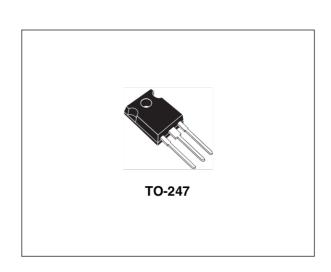
- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeability

### **Description**

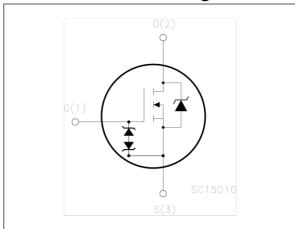
The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage Power MOSFETs including revolutionary MDmesh™ products

### **Applications**

■ Switching application



### Internal schematic diagram



### **Order codes**

| Part number | Part number Marking |        | Packaging |
|-------------|---------------------|--------|-----------|
| STW11NK90Z  | W11NK90Z            | TO-247 | Tube      |

Contents STW11NK90Z

# **Contents**

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STW11NK90Z Electrical ratings

# 1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol                             | Parameter   | Value      | Unit |
|------------------------------------|---|------------|------|
| V <sub>DS</sub>                    | Drain-source voltage (V <sub>GS</sub> = 0)          | 900        | V    |
| V <sub>DGR</sub>                   | Drain-gate voltage ( $R_{GS} = 20K\Omega$ )         | 900        | V    |
| V <sub>GS</sub>                    | Gate-source voltage                                 | ± 30       | V    |
| I <sub>D</sub>                     | Drain current (continuous) at T <sub>C</sub> = 25°C | 9.2        | Α    |
| I <sub>D</sub>                     | Drain current (continuous) at T <sub>C</sub> =100°C | 5.8        | Α    |
| I <sub>DM</sub> <sup>(1)</sup>     | Drain current (pulsed)                              | 36.8       | Α    |
| P <sub>TOT</sub>                   | Total dissipation at T <sub>C</sub> = 25°C          | 200        | W    |
|                                    | Derating factor                                     | 1.51       | W/°C |
| V <sub>ESD(G-D)</sub>              | Gate source ESD(HBM-C=100pF, R=1.5KΩ)               | 6000       | V    |
| dv/dt <sup>(2)</sup>               | Peak diode recovery voltage slope                   | 4.5        | V/ns |
| T <sub>J</sub><br>T <sub>stg</sub> | Operating junction temperature Storage temperature  | -55 to 150 | °C   |

<sup>1.</sup> Pulse width limited by safe operating area

Table 2. Thermal resistance

| Symbol                | Parameter                                      | Value | Unit |
|-----------------------|--|-------|------|
| R <sub>thj-case</sub> | Thermal resistance junction-case Max           | 0.66  | °C/W |
| R <sub>thj-a</sub>    | Thermal resistance junction-ambient Max        | 50    | °C/W |
| T <sub>I</sub>        | Maximum lead temperature for soldering purpose | 300   | °C   |

Table 3. Avalanche data

| Symbol          | Parameter   | Value | Unit |
|-----------------|---|-------|------|
| I <sub>AR</sub> | Avalanche current, repetitive or not-repetitive (pulse width limited by Tj Max) |       | А    |
| E <sub>AS</sub> | Single pulse avalanche energy (starting Tj=25°C, Id=lar, Vdd=50V)               | 400   | mJ   |

<sup>2.</sup>  $I_{SD} \leq 9.2 \text{A}, \, \text{di/dt} \leq 200 \text{A/}\mu\text{s}, \, V_{DD} = 80\% V_{(BR)DSS}$ 

Electrical characteristics STW11NK90Z

# 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 4. On/off states

| Symbol               | Parameter   | Test conditions  | Min. | Тур. | Max.    | Unit     |
|----------------------|---|--|------|------|---------|----------|
| V <sub>(BR)DSS</sub> | Drain-source breakdown voltage                        | I <sub>D</sub> = 1mA, V <sub>GS</sub> = 0              | 900  |      |         | V        |
| I <sub>DSS</sub>     | Zero gate voltage drain current (V <sub>GS</sub> = 0) | $V_{DS} = Max rating,$<br>$V_{DS} = Max rating @125°C$ |      |      | 1<br>50 | μA<br>μA |
| I <sub>GSS</sub>     | Gate body leakage current (V <sub>DS</sub> = 0)       | V <sub>GS</sub> = ±20V                                 |      |      | ±10     | μА       |
| V <sub>GS(th)</sub>  | Gate threshold voltage                                | $V_{DS} = V_{GS}$ , $I_D = 100\mu A$                   | 3    | 3.75 | 4.5     | V        |
| R <sub>DS(on)</sub>  | Static drain-source on resistance                     | V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.6A           |      | 0.82 | 0.98    | Ω        |

Table 5. Dynamic

| Symbol   | Parameter   | Test conditions  | Min. | Тур.              | Max. | Unit           |
|--|---|--|------|-------------------|------|----------------|
| 9 <sub>fs</sub> (1)                                      | Forward transconductance  | V <sub>DS</sub> =15V, I <sub>D</sub> = 4.6A                      |      | 11                |      | S              |
| C <sub>iss</sub><br>C <sub>oss</sub><br>C <sub>rss</sub> | Input capacitance Output capacitance Reverse transfer capacitance | V <sub>DS</sub> =25V, f=1 MHz, V <sub>GS</sub> =0                |      | 3000<br>240<br>48 |      | pF<br>pF<br>pF |
| Coss eq <sup>(2)</sup> .                                 | Equivalent output capacitance                                     | V <sub>GS</sub> =0, V <sub>DS</sub> =0V to 720V                  |      | 83                |      | pF             |
| Q <sub>g</sub><br>Q <sub>gs</sub><br>Q <sub>gd</sub>     | Total gate charge<br>Gate-source charge<br>Gate-drain charge      | $V_{DD}$ =720V, $I_D$ = 9.2A<br>$V_{GS}$ =10V<br>(see Figure 14) |      | 95<br>14<br>49    | 115  | nC<br>nC<br>nC |

<sup>1.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 6. Switching times

| Symbol                                   | Parameter   | Test conditions   | Min. | Тур.                 | Max. | Unit                 |
|--|---|---|------|----------------------|------|----------------------|
| $t_{d(on)}$ $t_{r}$ $t_{d(off)}$ $t_{f}$ | Turn-on delay time<br>Rise time<br>Turn-off delay time<br>Fall time | $V_{DD}$ =450 V, $I_{D}$ = 4.6A, $R_{G}$ =4.7 $\Omega$ V <sub>GS</sub> =10V (see Figure 13) |      | 30<br>19<br>76<br>50 |      | ns<br>ns<br>ns<br>ns |

<sup>2.</sup>  $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  inceases from 0 to 80%  $V_{DSS}$ 

Table 7. Source drain diode

| Symbol   | Parameter  | Test conditions   | Min. | Тур.             | Max. | Unit          |
|--|--|---|------|------------------|------|---------------|
| I <sub>SD</sub>  | Source-drain current   |   |      |                  | 9.2  | Α             |
| I <sub>SDM</sub> <sup>(1)</sup>                        | Source-drain current (pulsed)  |   |      |                  | 36.8 | Α             |
| V <sub>SD</sub> <sup>(2)</sup>                         | Forward on voltage   | I <sub>SD</sub> =9.2A, V <sub>GS</sub> =0   |      |                  | 1.6  | V             |
| t <sub>rr</sub><br>Q <sub>rr</sub><br>I <sub>RRM</sub> | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD}$ =9.2A,<br>di/dt = 100A/ $\mu$ s,<br>$V_{DD}$ =50V, Tj=25°C<br>(see Figure 18)          |      | 584<br>6<br>21   |      | ns<br>μC<br>Α |
| t <sub>rr</sub><br>Q <sub>rr</sub><br>I <sub>RRM</sub> | Reverse recovery time Reverse recovery charge Reverse recovery current | I <sub>SD</sub> =9.2A,<br>di/dt = 100A/μs,<br>V <sub>DD</sub> =50V, Tj=150°C<br>(see Figure 18) |      | 790<br>8.7<br>22 |      | ns<br>μC<br>Α |

<sup>1.</sup> Pulse width limited by safe operating area

Table 8. Gate-source zener diode

| Symbol                           | Parameter                     | Test conditions       | Min. | Тур. | Мах. | Unit |
|----------------------------------|-------------------------------|-----------------------|------|------|------|------|
| BV <sub>GSO</sub> <sup>(1)</sup> | Gate-source breakdown voltage | lgs=±1mA (open drain) | 30   |      |      | V    |

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

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<sup>2.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%

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# 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

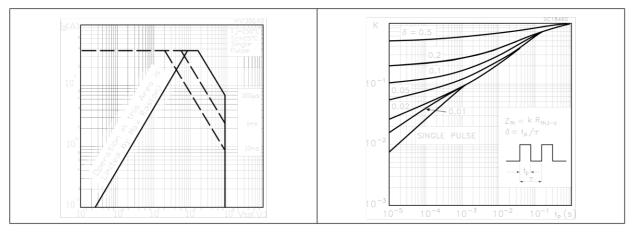


Figure 3. Output characterisics

Figure 4. Transfer characteristics

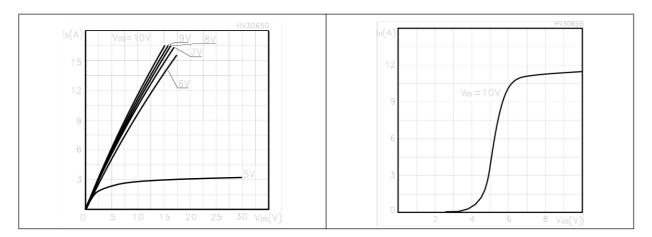


Figure 5. Normalized B<sub>VDSS</sub> vs temperature

Figure 6. Static drain-source on resistance

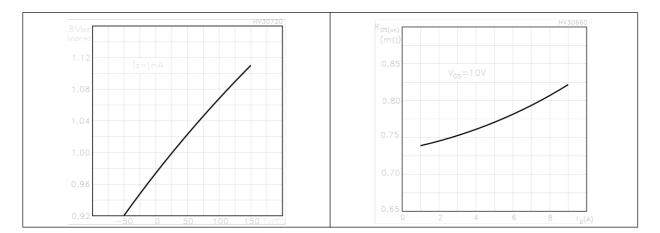


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

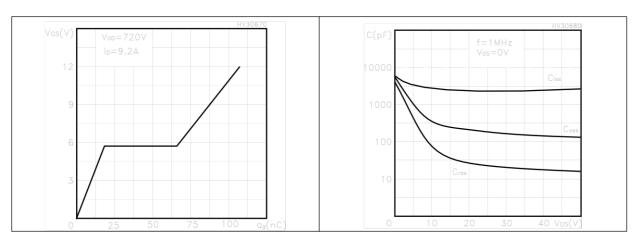


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

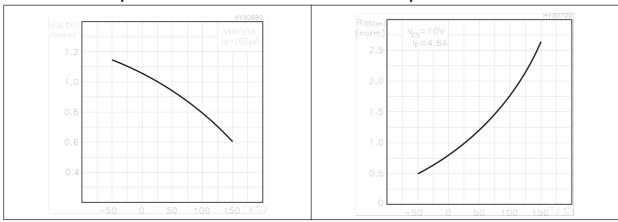
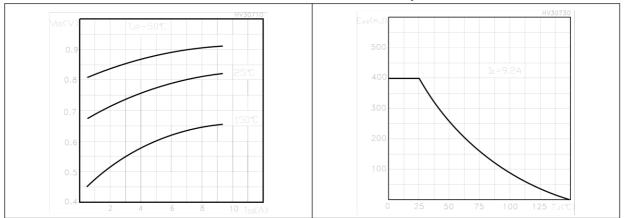


Figure 11. Source-drain diode forward characteristics

Figure 12. Maximum avalanche energy vs temperature



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Test circuits STW11NK90Z

# 3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

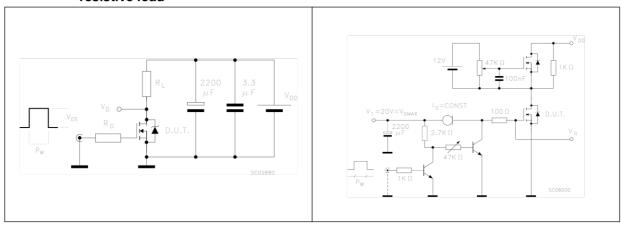


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped Inductive load test circuit

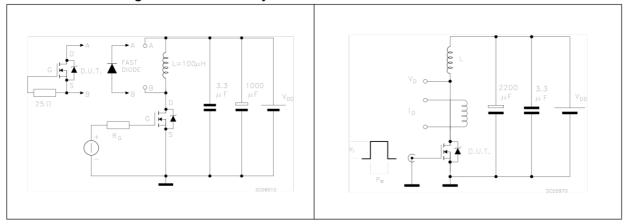
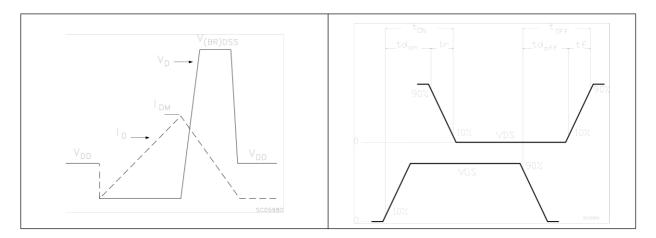


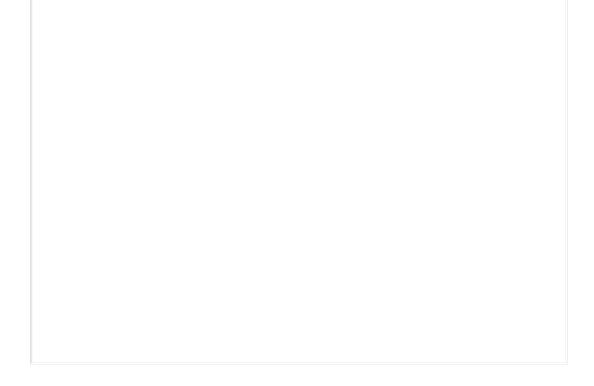
Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



# 4 Package mechanical data

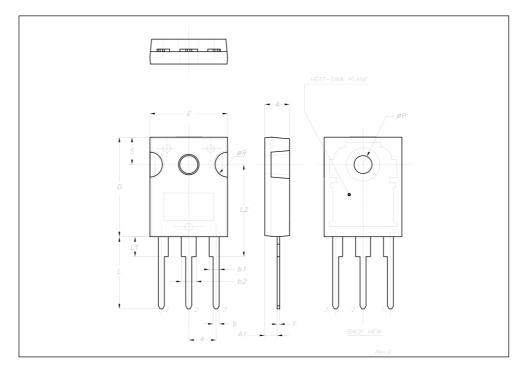
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: <a href="https://www.st.com">www.st.com</a>



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#### **TO-247 MECHANICAL DATA**

| DIM  |       | mm.   |       |       | inch  |       |
|------|-------|-------|-------|-------|-------|-------|
| DIM. | MIN.  | TYP   | MAX.  | MIN.  | TYP.  | MAX.  |
| Α    | 4.85  |       | 5.15  | 0.19  |       | 0.20  |
| A1   | 2.20  |       | 2.60  | 0.086 |       | 0.102 |
| b    | 1.0   |       | 1.40  | 0.039 |       | 0.055 |
| b1   | 2.0   |       | 2.40  | 0.079 |       | 0.094 |
| b2   | 3.0   |       | 3.40  | 0.118 |       | 0.134 |
| С    | 0.40  |       | 0.80  | 0.015 |       | 0.03  |
| D    | 19.85 |       | 20.15 | 0.781 |       | 0.793 |
| E    | 15.45 |       | 15.75 | 0.608 |       | 0.620 |
| е    |       | 5.45  |       |       | 0.214 |       |
| L    | 14.20 |       | 14.80 | 0.560 |       | 0.582 |
| L1   | 3.70  |       | 4.30  | 0.14  |       | 0.17  |
| L2   |       | 18.50 |       |       | 0.728 |       |
| øΡ   | 3.55  |       | 3.65  | 0.140 |       | 0.143 |
| øR   | 4.50  |       | 5.50  | 0.177 |       | 0.216 |
| S    |       | 5.50  |       |       | 0.216 |       |



STW11NK90Z Revision history

# 5 Revision history

Table 9. Revision history

| Date        | Revision | Changes                          |
|-------------|----------|----------------------------------|
| 30-Mar-2006 | 1        | First release                    |
| 25-Jul-2006 | 2        | Modified value on Avalanche data |

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